Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | PATTON ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,625,690 A	04-1997	Michel et al.	705/53
*	В	US-2001/0024510 A1	09-2001	Iwamura, Keiichi	382/100
*	С	US-2001/0054081 A1	12-2001	Fujiwara, Yasuhisa	709/217
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	7	US-			
:	Κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				, , , , , , , , , , , , , , , , , , , ,	
	0					
	Р	•				
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	٧					
	w					
	x					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.